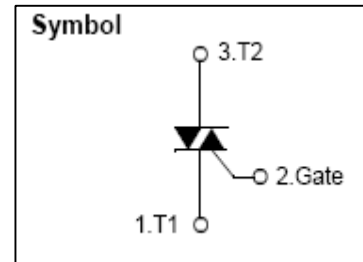


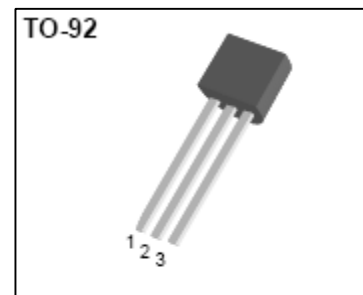
### Features

- Repetitive Peak off-State Voltage: 800V
- R.M.S On-State Current( $I_{T(RMS)}=1A$ )
- Low on-state voltage:  $V_{TM}=1.2(\text{typ.})@ I_{TM}$
- Low reverse and forward blocking current:  
 $I_{DRM}=500\mu A@TC=125^{\circ}C$
- Low holding current:  $I_H=4mA$  (typ.)
- High Commutation  $dV/dt$ .



### General Description

General purpose switching and phase control applications. These devices are intended to be interfaced directly to micro-controllers, logic integrated circuits and other low power gate trigger circuits such as fan speed and temperature modulation control, lighting control and static switching relay.



### Absolute Maximum Ratings ( $T_J=25^{\circ}C$ unless otherwise specified)

Symbol	Parameter	Value	Units
$V_{DRM}$	Peak Repetitive Forward Blocking Voltage(gate open) (Note 1)	800	V
$T_{(RMS)}$	Forward Current RMS (All Conduction Angles, $T_L=50^{\circ}C$ )	1	A
$I_{TSM}$	Peak Forward Surge Current, (full Cycle, Sine Wave, 50/60 Hz)	9.1/10	A
$I^2t$	Circuit Fusing Considerations ( $t_p=10$ ms)	0.41	$A^2s$
$P_{GM}$	Peak Gate Power — Forward, ( $T_c=58^{\circ}C$ , Pulse with $\leq 1.0\mu s$ )	5	W
$P_{G(AV)}$	Average Gate Power — Forward, (Over any 20ms period)	0.1	W
$dI/dt$	Critical rate of rise of on-state current $I_{TM}=1.5A$ ; $I_G=200mA$ ; $dI_G/dt=200mA/\mu s$ $T_J=125^{\circ}C$	50	$A/\mu s$
$I_{FGM}$	Peak Gate Current — Forward, $T_J=125^{\circ}C$ (20 $\mu s$ , 120 PPS)	0.5	A
$V_{RGM}$	Peak Gate Voltage — Reverse, $T_J=125^{\circ}C$ (20 $\mu s$ , 120 PPS)	6	V
$T_{J_i}$	Junction Temperature	-40~125	$^{\circ}C$
$T_{stg}$	Storage Temperature	-40~150	$^{\circ}C$
	mass	2	g

**Note1:** Although not recommended, off-state voltages up to 800V may be applied without damage, but the TRIAC may switch to the on-state. The rate of rise of current should not exceed  $3A/\mu s$ .

### Thermal Characteristics

Symbol	Parameter	Value			Units
		Min	Typ	Max	
$R_{QJC}$	Thermal Resistance, Junction-to-Case	-	-	60	$^{\circ}C/W$
$R_{QJA}$	Thermal Resistance, Junction-to-Ambient	-	-	120	$^{\circ}C/W$

## Electrical Characteristics (T<sub>J</sub> = 25°C unless otherwise specified)

Symbol	Characteristics	Min	Typ.	Max	Unit	
I <sub>DRM</sub>	Peak Forward or Reverse Blocking Current (V <sub>D</sub> = V <sub>DRM</sub> /V <sub>RRM</sub> , gate open)	-	-	5	μA	
		-	-	500		
V <sub>TM</sub>	Forward "On" Voltage (I <sub>TM</sub> = 1.5 A)	-	1.2	1.5	V	
			(Note2)			
I <sub>GT</sub>	Gate Trigger Current (Continuous dc) (V <sub>D</sub> = 12 Vdc, R <sub>L</sub> = 33 Ω)	-	0.4	5	mA	
		-	1.3	5		
		-	1.4	5		
		-	3.8	7		
V <sub>GT</sub>	Gate Trigger Voltage (Continuous dc) (V <sub>D</sub> = 12 Vdc, R <sub>L</sub> = 33 Ω)	-	-	1.2	V	
		-	-	1.2		
		-	-	1.2		
		-	-	1.5		
V <sub>GD</sub>	Gate threshold voltage(T <sub>J</sub> =125°C, V <sub>D</sub> =V <sub>DRM</sub> , R <sub>L</sub> =3.3KΩ)	0.2	-	-	V	
dV/dt	Critical rate of rise of commutation Voltage (V <sub>D</sub> =0.67V <sub>DRM</sub> , gate open)	10	20	-	V/μs	
I <sub>H</sub>	Holding Current (V <sub>D</sub> = 12 V, I <sub>GT</sub> = 100 mA)	-	1.3	5	mA	
I <sub>L</sub>	latching current (V <sub>D</sub> = 12 V; I <sub>GT</sub> = 100 mA)	T2+G+	-	1.2	5	mA
		T2+G-	-	4.0	8	
		T2-G-	-	1.0	5	
		T2-G+	-	2.5	8	
R <sub>d</sub>	Dynamic resistance (T <sub>J</sub> =125°C)	-	-	420	mΩ	

Note 2. Forward current applied for 1 ms maximum duration, duty cycle

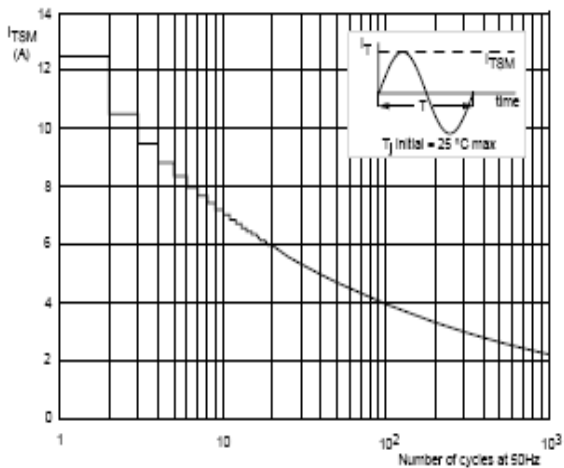


Fig. 1 Maximum permissible non-repetitive peak on-state current  $I_{TSM}$ , versus number of cycles, for sinusoidal currents,  $f = 50$  Hz.

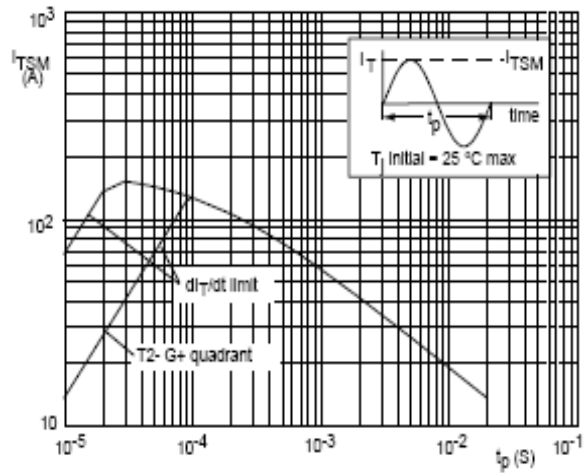


Fig. 2 Maximum permissible non-repetitive peak on-state current  $I_{TSM}$ , versus pulse width  $t_p$ , for sinusoidal currents,  $t_p \leq 20$ ms.

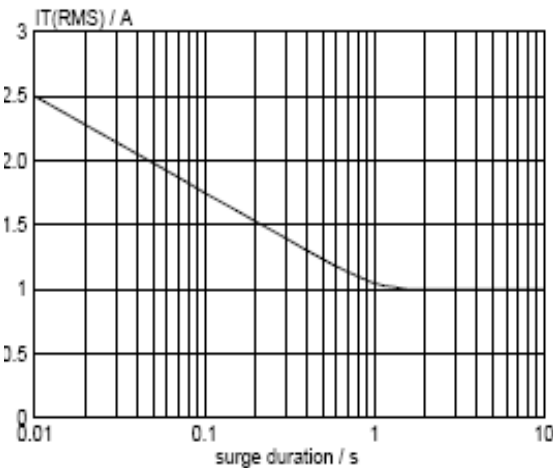


Fig. 3 Maximum permissible repetitive rms on-state current  $I_{T(RMS)}$ , versus surge duration, for sinusoidal currents,  $f = 50$  Hz;  $T_{lead} \leq 66^\circ\text{C}$ .

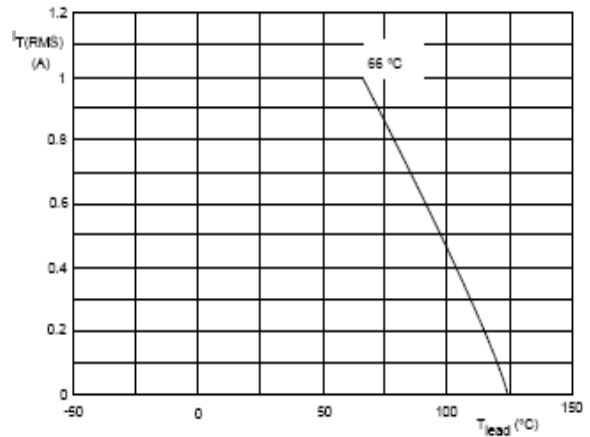


Fig. 4 Maximum permissible rms current  $I_{T(RMS)}$ , versus lead temperature  $T_{lead}$ .

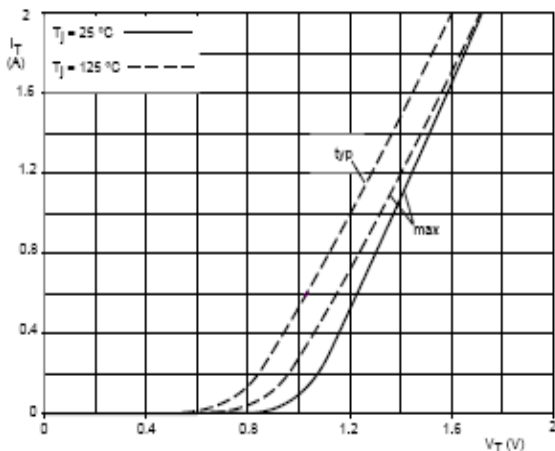


Fig. 5 Typical and maximum on-state characteristic.

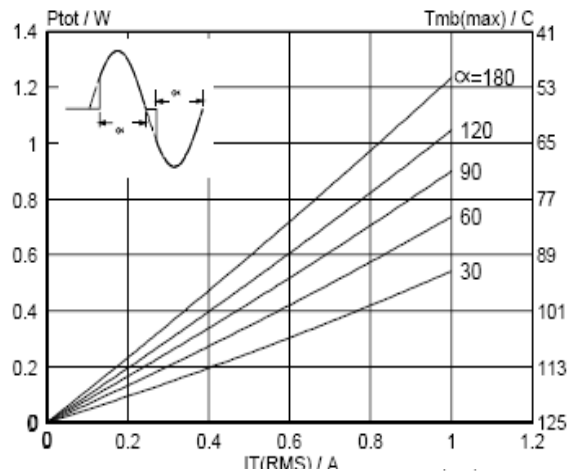


Fig. 6 Maximum on-state dissipation,  $P_{tot}$ , versus rms on-state current,  $I_{T(RMS)}$ , where  $\alpha =$  conduction angle.

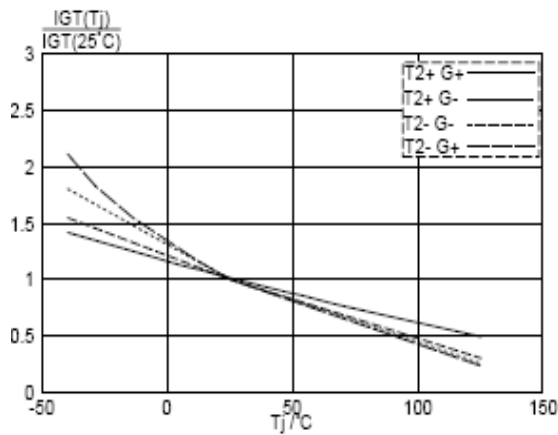


Fig. 7. Normalised gate trigger current  $I_{GT}(T_j)/I_{GT}(25^\circ\text{C})$ , versus junction temperature  $T_j$ .

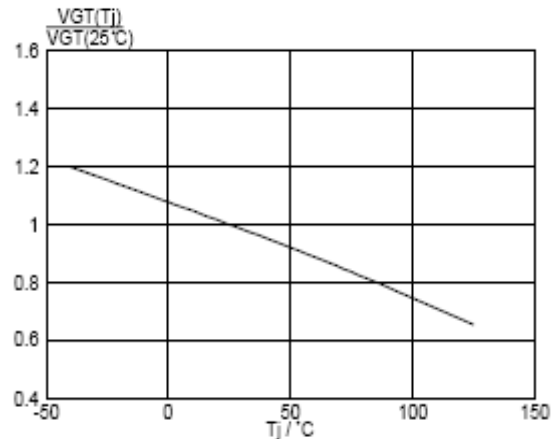


Fig. 8. Normalised gate trigger voltage  $V_{GT}(T_j)/V_{GT}(25^\circ\text{C})$ , versus junction temperature  $T_j$ .

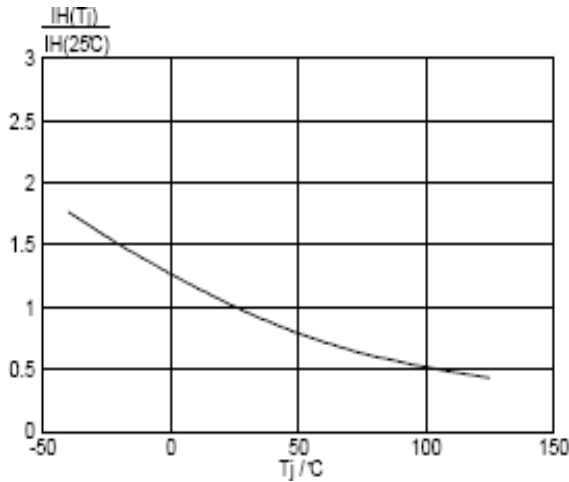


Fig. 9. Normalised holding current  $I_H(T_j)/I_H(25^\circ\text{C})$ , versus junction temperature  $T_j$ .

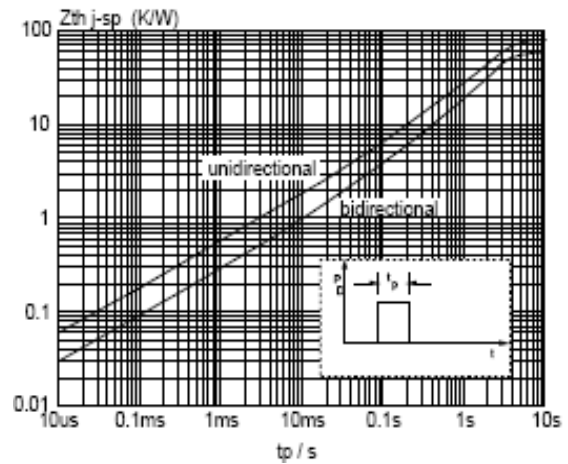


Fig. 10 Transient thermal impedance  $Z_{th(j-lead)}$ , versus pulse width  $t_p$ .

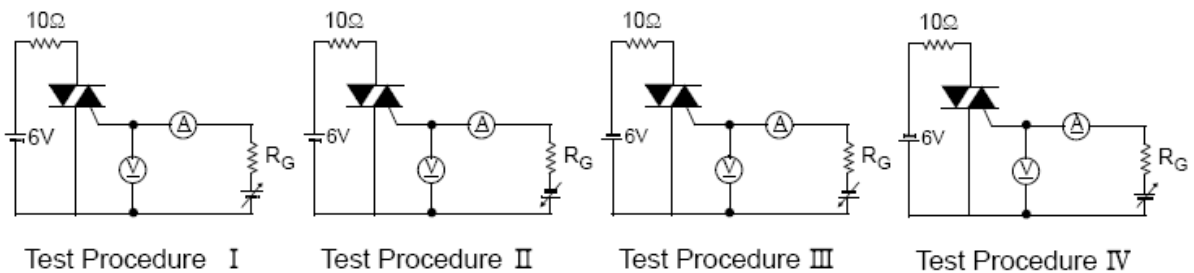


Fig. 11 Gate Trigger Characteristics Test Circuit

TO-92 Package Dimension

